## Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10717607	KIM ET AL.
Examiner	Art Unit
Keefer, Michael E	2454

SEARCHED				
Class	Subclass	Date	Examiner	
709	227 (updated 12/5/2008)	7/13/2007	MEK	

SEARCH NOTES			
Search Notes	Date	Examiner	
EAST Search	7/13/2007	MEK	
Consulted Examiner Hassan Phillips	7/12/2007	MEK	
Consulted Examiner Dustin Nguyen	7/12/2007	MEK	
Consulted Examiner Hassan Phillips, class 709	12/2/2008	MEK	
Consulted Primary Examiner Dustin Nguyen, class 709	12/5/2008	MEK	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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